

NUMERICAL INDEX — DIVISION 668

DATA TEST CENTERS

1. GENERAL

1.01 This section provides an index of sections in Division 668. Also, it provides within layers, subdivision numbers to be used, when required, by the Bell Operating Companies and the Long Lines Department for locally prepared sections in this division.

1.02 A bullet (●) indicates an item that has been added or changed since the previous issue of the index.

1.03 A square (□) indicates a canceled item. Information relating to the cancellation, if necessary, will be shown in a note following the item. Canceled items and related notes will be deleted upon reissue of the index.

1.04 A heart (♥) indicates a new or reissued item which, because of its limited need, will not be distributed on standing order except through coded distribution. Additional copies may be obtained by placing regular (one-time) orders.

1.05 A spade (♠) indicates an item not on microfiche. This index indicates the latest issue for hard-copy practices. In some cases, the microfiche will reflect the next higher issue as a result of the reduced distribution interval.

1.06 "Add" is the abbreviation for Addendum, and "Sup" is the abbreviation for Supplement.

2. LAYERS

2.01 This division is arranged in layers as follows:

- 668-0 Indexes, Equipment Test Lists, and General Information
- 1 904A, B, C, and D Data Test Centers
 - 2 904E Data Test Center
 - 3 Supplementary 904-Type Data Test Centers
 - 4 904G-, H-, and I-Type Data Test Centers
 - 6 Automatic Data Test System

3. INDEX

Section Number	Issue	Subject
668-0 INDEXES, EQUIPMENT TEST LISTS, AND GENERAL INFORMATION		
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668-000-500	7	904A, B, C, and D Data Test Center — Inspection and Maintenance Tests
Sup 668-001-011	1	
668-001-011	1	ETL

668-010 DATAPHONE Service on DDD

668-010-300	2	Data Systems — DATA-PHONE® Service and Other Data Services on the Direct Distance Dialing Network — Trouble Analysis Procedures
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668-1 904A, B, C, AND D DATA TEST CENTERS

668-100-100	7	904A-, B-, C-, and D-Types — Description
668-100-500	4	904A- and 904C-Types — Operation
668-100-501	6	904B- and 904D-Type — Operation
668-101-500	3	904A- and 904C-Types — Test Procedures — Data Set 103A-Type — Loop-Back Test

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668-101-502	3	904A- and 904C-Type — Test Procedure — Data Set 103F-Type Loop-Back Test
668-101-503	4	904A- and 904C-Types — Test Procedure — Data Sets 103A3, 103E-, 103G-, and 103H-Types — Loop-Back Test
668-101-504	1	904A/C and 904B/D Data Test Centers — Test Procedures — Data Set 103J-Type
668-101-510	1	904A- and 904C-Type — Test Procedure — Data Sets 108A- and 108C-Types — Loop-Back Test
668-101-511	3	904A/C and 904B/D — Test Procedure — Data Set 113A-Type — Loop-Back Test
668-101-512	1	904A- and 904C-Type Test Procedure — Data Set 112A-Type Loop-Back Test
668-101-513	1	904A- and 904C-Type — Test Procedure — Data Set 113B-L1 — Loop-Back Test
668-101-514	1	904A/C and 904B/D Data Test Centers — Test Procedures — Data Set 113C-Type
668-101-515	1	904A/C and 904B/D Data Test Centers — Test Procedures — Data Set 113D-Type

668-102 904A, B, C, and D Data Test Centers

668-102-500	4	904B- and 904D-Types — Test Procedure — Data Sets 201A- and 201B-Types — Dynamic Test
668-102-501	1	904A/C and 904B/D Test Procedures — Data Set 201C-Type
668-102-510	3	904B and 904D Types — Test Procedure — Data Sets 202A and 202B — Dynamic Test
668-102-511	1	904A- and 904C-Types — Test Procedure — Data Set 202A and 202B Loop-Back Test
668-102-512	5	904A/B and 904C/D — Test Procedure — Data Sets 202C- and 202D-Types — Loop-Back and Dynamic Tests
668-102-513	4	904A/B and 904C/D Test Procedure — Data Set 202E

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668-102-541	2	904C and 904D-Types — Test Procedures — Data Set 205C-Type — Loopback Test
668-102-550	1	Test Procedures — Data Set 208A-Type
668-102-551	2	904A/B and 904C/D Data Test Centers — Test Procedures — Data Set 208B-L1
668-102-552	1	904A/B and 904B/D Data Test Centers — Test Procedures — 209A-Type Data Set
668-102-555	2	904A/C and 904B/D — Test Procedures Data Set 212A

668-104 904A, B, C, and D Data Test Centers

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668-104-500	3	904A- and 904C-Types — Test Procedure — Data Set 401A — Remote Test
668-104-501	3	904A- and 904C-Types — Test Procedures — Data Set 401B
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668-104-503	3	904A- and 904C-Type — Test Procedure — Data Set 401F — Loop-Back Test
668-104-504	4	904A and 904C-Types — Test Procedure — Data Set 401H-Type
668-104-505	4	904A- and 904C-Type — Test Procedures — Data Set 401J-Type Loop-Back and End-to-DTC Interface Test
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668-104-520	2	904A- and 904C-Types — Test Procedure — Data Set 402A Semi-Dynamic Test
668-104-521	2	904A- and 904C-Types — Test Procedure — Data Set 402B
668-104-522	5	904A- and 903C-Types — Test Procedure — Data Set 402C-Type — Loopback and Dynamic Tests
668-104-523	3	904A- and 904C-Types — Test Procedure — Data Set 402D-Type
668-104-530	2	904A- and 904C-Types — Test Procedure — Data Set 403A Loop-Back Test
Add 668-104-531	1	
668-104-531	4	904A- and 904C-Types — Test Procedure — Data Sets 403D9, 10, 11, and 12, and 403E5 and 6
668-104-532	2	904A- and 904C-Types — Test Procedure — Data Sets 403D13 and 14, and 403E7 Loop-Back Tests

Section Number	Issue	Subject
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668-104-590	1	904A- and 904C-Type — Test Procedure — Data Stations Equipped With 12 Button TOUCH-TONE® Dials

668-106 Data Test Center 904A- and 904C-Type

668-106-500	2	Test Procedure — Data Sets 601A and 601B
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♥ 668-106-515	2	Test Procedure — Data Set 604A-Type
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668-108-500	3	Test Procedure — Data Auxiliary Set 801A-Type
668-108-501	3	Test Procedures — 801CR-Type and 801C List-Type Data Auxiliary Sets
668-108-510	3	Test Procedure — Data Auxiliary Set 806A-Type
668-110-500	1	Test Procedure for Data Access Arrangements
668-120-500	2	904B- and 904D-Types — Test Procedure — Type 1 and 2 DATASPEED® Tape Sender — Dynamic Test
668-120-501	3	904B- and 904D-Types Test Procedure — Type 5 DATASPEED® Tape Senders
668-120-502	1	DATASPEED® 2A Tape Sender Station — Test Procedures Using DATASPEED® 40 Test Set
668-121-500	1	904B- and 904D-Types — Test Procedure — DATASPEED® Tape Receiver Unit — Dynamic Test
668-121-501	1	Test Procedure — Type 5 DATASPEED® Tape Receiver
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668-125-504	1	DATASPEED® 40/4 4540 Test Procedures Using a 18388 Test Set Generator (TSG 40/4)
668-125-507	1	Synchronous DATASPEED® 40/4 — Direct Distant Dialed — Single Display Station — BSC Protocol — Testing Using Pacer M-103 LB1/2 Data Line Monitor/Simulator
668-125-508	1	DATASPEED® 40/4 Test Procedures Using Pacer — 103 LB1 Dataline Monitor/Simulator
668-125-509	2	Integrated Synchronous DATASPEED® 40 Receive-Only — Printer Station Testing Using Pacer M103-LB1 or LB2 Test Set
668-125-510	1	DATASPEED® 4540 Printer Line Display Station for ADCCP System Applications Testing — Using Pacer M-103-L3 V2 Data Line Monitor/Simulator
668-125-511	1	Synchronous DATASPEED® 40/4 — 4540 BLSYNC — Test Procedures (1/4ATC4 and 1/4ETC4) Using Pacer-103, LB1/2 Data Line Monitor/Simulator
668-126-500	1	2510/2511 CDT Private Line — BISP Stations — STC/DTC Test Procedures — Using DATASPEED® 40 Test Position
668-127-500	1	DATASPEED® RO Page Printer — Switched Network Service — Test Procedures — Using DATASPEED® 40 Test Position
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668-130-502	1	The 43 Basic Teleprinter (ASCII) with Selective Calling Feature for Private Line Applications Testing — Using DATASPEED® 40 Test Position
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668-130-504	1	43 Teleprinter 8-Level Buffered Selective Calling (BSC) — Station Testing Using DATASPEED® 40 Test Position
668-130-505	2	43 Teleprinter 5-Level Buffered Selective Calling (BSC) Station Testing Using 921A Data Test Set or 28-Type KSR or TEKTRONIX® Model — 834 Data Communications Tester
668-140-500	1	COMM-STOR† II Communications Storage Unit — Remote Test Procedures
668-140-501	1	COMM-STOR† II Communications Storage Unit — Equipped With 8A1/8B1 Protocol Option — Remote Testing Procedures

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†Registered Trademark of Sykes Datatronics, Inc.

Section Number	Issue	Subject
668-140-503	1	Line Control Unit (LCU) — Remote Test Procedures — COMM-STOR* II Communications Storage Unit

668-2 904E DATA TEST CENTER

668-200-500	1	Operation
668-200-501	1	Inspection and Maintenance Tests
668-202-500	1	Test Procedure — Data Set 205A — Loop-Back Test
668-204-500	1	Test Procedure — Data Set 404A — Loop-Back Test
668-206-500	2	Test Procedures — Data Set 602B-Type

668-3 SUPPLEMENTARY 904-TYPE DATA TEST CENTERS

668-300-100	1	Description
668-301-101	1	DATAPHONE® II Service Testing — Signal Quality Interpretation Performance Maintenance Operations Control Centers
668-301-500	1	DATAPHONE® II Service Test Position — Test Procedures
668-302-500	2	Use of 904F Position With 904C and 904D Data Test Centers — Test Procedures — Data Set 207-Type — Loop-Back — Dynamic Tests
668-302-501	1	Use of 904F Position With 904C and 904D Data Test Centers — Test Procedures — Data Set 205B-Types — Loop-Back — Dynamic Tests
668-302-502	1	Use of 904F Position With 904C and 904D Data Test Centers — Test Procedures — Data Set 205C-Type — Loop-Back — Dynamic Tests

668-4 904G-, H-, AND L-TYPE DATA TEST CENTERS

668-400-100	5	Description and Operation
668-400-500	4	Inspection and Maintenance Tests
668-400-501	1	Station Tests
668-400-502	1	Test Procedures — Data Set 103J

AT&T 668-000-000

Section Number	Issue	Subject
668-6 AUTOMATIC DATA TEST SYSTEM (ADTS)		
668-600-100	3	J1P005 — Description
668-600-101	3	J1P005 — Operation From Local Terminals
668-600-102	3	J1P005 — Operation From a Remote Terminal
668-600-190	1	Engineering and Implementation Method System

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668-600-300	4	J1P005 — Maintenance
668-600-500	4	J1P005 — Operating Procedures
668-600-501	3	J1P005 — Off-Line Maintenance Procedures
668-600-502	3	J1P005 — Automatic Voice Answer-Data Test (AVA-DT) — Maintenance Procedures